

<b>Notice of References Cited</b>	Application/Control No. 09/731,193	Applicant(s)/Patent Under Reexamination NAKAMURA ET AL.	
	Examiner Dung Nguyen	Art Unit 2871	Page 1 of 1

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*	B	US-6,445,437	09-2002	Miyazaki et al.	349/156
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